Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/729,865	CHEN ET AL.	
Examiner	Art Unit	
VanThu Nguyen	2824	

SEARCHED			
Class	Subclass	Date	Examiner
365	185.11 185.13 x 185.17 o	1/5/2006	VTN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST Search	1/5/2006	VTN